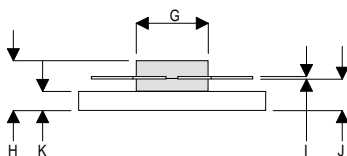
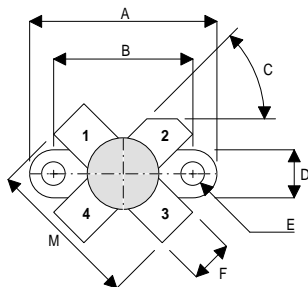


MECHANICAL DATA



DA

PIN 1 SOURCE PIN 2 DRAIN
 PIN 3 SOURCE PIN 4 GATE

DIM	mm	Tol.	Inches	Tol.
A	24.76	0.13	0.975	0.005
B	18.42	0.13	0.725	0.005
C	45°	5°	45°	5°
D	6.35	0.13	0.25	0.005
E	3.17	0.13	0.125 DIA	0.005
F	5.71	0.13	0.225	0.005
G	9.52	0.13	0.375	0.005
H	6.60	REF	0.260	REF
I	0.13	0.02	0.005	0.001
J	4.32	0.13	0.170	0.005
K	2.54	0.13	0.100	0.005
M	20.32	0.25	0.800	0.010

**GOLD METALLISED
 MULTI-PURPOSE SILICON
 DMOS RF FET
 10W – 12.5V – 175MHz
 SINGLE ENDED**

FEATURES

- SIMPLIFIED AMPLIFIER DESIGN
- SUITABLE FOR BROAD BAND APPLICATIONS
- LOW C_{rss}
- SIMPLE BIAS CIRCUITS
- LOW NOISE
- HIGH GAIN – 10 dB MINIMUM

APPLICATIONS

- HF/VHF/UHF COMMUNICATIONS
 from 1 MHz to 175 MHz

ABSOLUTE MAXIMUM RATINGS ($T_{case} = 25^{\circ}C$ unless otherwise stated)

P_D	Power Dissipation	50W
BV_{DSS}	Drain – Source Breakdown Voltage	40V
BV_{GSS}	Gate – Source Breakdown Voltage	$\pm 20V$
$I_{D(sat)}$	Drain Current	10A
T_{stg}	Storage Temperature	-65 to 150°C
T_j	Maximum Operating Junction Temperature	200°C

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ELECTRICAL CHARACTERISTICS (T_{case} = 25°C unless otherwise stated)

Parameter	Test Conditions	Min.	Typ.	Max.	Unit
B _V DSS Drain–Source Breakdown Voltage	V _{GS} = 0 I _D = 100mA	40			V
I _D DSS Zero Gate Voltage Drain Current	V _{DS} = 12.5V V _{GS} = 0			1	mA
I _G DSS Gate Leakage Current	V _{GS} = 20V V _{DS} = 0			1	μA
V _{GS(th)} Gate Threshold Voltage*	I _D = 10mA V _{DS} = V _{GS}	1		7	V
g _{fs} Forward Transconductance*	V _{DS} = 10V I _D = 1A	0.8			S
G _{PS} Common Source Power Gain	P _O = 10W	10			dB
η Drain Efficiency	V _{DS} = 12.5V I _{DQ} = 0.4A	50			%
VSWR Load Mismatch Tolerance	f = 175MHz	20:1			—
C _{iss} Input Capacitance	V _{DS} = 0 V _{GS} = -5V f = 1MHz			60	pF
C _{oss} Output Capacitance	V _{DS} = 12.5V V _{GS} = 0 f = 1MHz			40	pF
C _{rss} Reverse Transfer Capacitance	V _{DS} = 12.5V V _{GS} = 0 f = 1MHz			4	pF

* Pulse Test: Pulse Duration = 300 μs , Duty Cycle ≤ 2%

HAZARDOUS MATERIAL WARNING

The ceramic portion of the device between leads and metal flange is beryllium oxide. Beryllium oxide dust is highly toxic and care must be taken during handling and mounting to avoid damage to this area.

THESE DEVICES MUST NEVER BE THROWN AWAY WITH GENERAL INDUSTRIAL OR DOMESTIC WASTE.

THERMAL DATA

R _{THj-case}	Thermal Resistance Junction – Case	Max. 3.5°C / W
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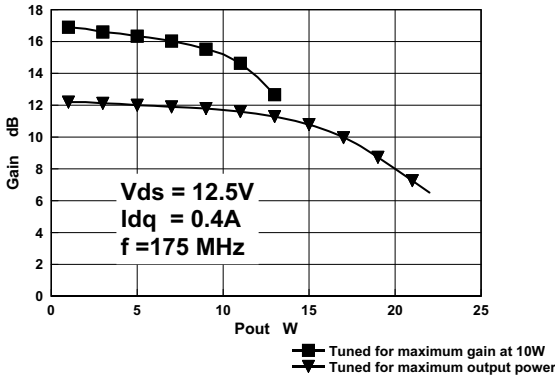


Figure 1 – Gain vs. Power Output.

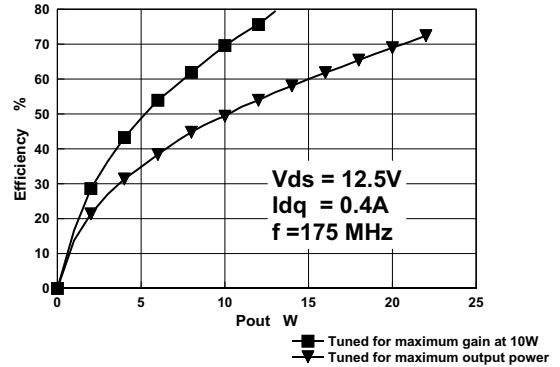


Figure 2 – Efficiency vs. Power Output.

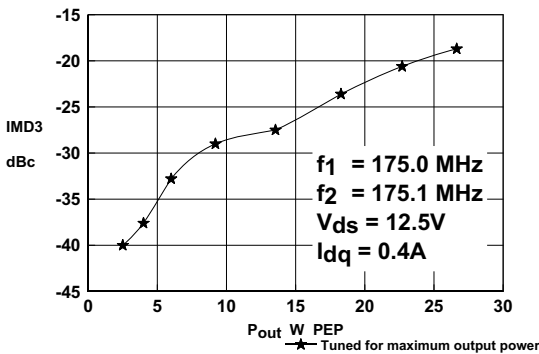


Figure 3 – IMD vs. Power Output.

D1210UK OPTIMUM SOURCE AND LOAD IMPEDANCE

Frequency MHz	Z _S Ω	Z _L Ω
175MHz	7.2 + j15	4.1 - j2.5

! V_{DS} = 12.5V, I_{DQ} = 0.4A
MHz S M A R 50

Typical S Parameters

! V_{DS} = 12.5V, I_{DQ} = 0.4A
MHz S M A R 50

IFreq MHz	S11		S21		S12		S22	
	mag	ang	mag	ang	mag	ang	mag	ang
50	0.7	-116.5	14.93	97.9	0.036	15.7	0.64	-108.4
100	0.7	-140	7.42	73.6	0.03	2.7	0.65	-132
150	0.75	-150.2	4.56	58.1	0.02	11	0.71	-143.1
200	0.81	-157.2	3.1	46.5	0.016	52.3	0.78	-151.2
250	0.85	-163.1	2.23	37.4	0.026	82.6	0.83	-157.9
300	0.88	-168.1	1.67	30.3	0.04	90.1	0.86	-163.7
350	0.9	-172.6	1.3	24.7	0.055	90.8	0.89	-168.8
400	0.92	-176.6	1.04	20.3	0.071	89.2	0.91	-173.4
450	0.93	-179.7	0.85	17.1	0.086	86.8	0.92	-177.5
500	0.94	-176.3	0.71	14.9	0.101	84.2	0.93	-178.7
550	0.95	-173.1	0.6	13.5	0.115	81.5	0.94	-175.2
600	0.95	-170.1	0.52	13	0.13	78.8	0.95	-171.9

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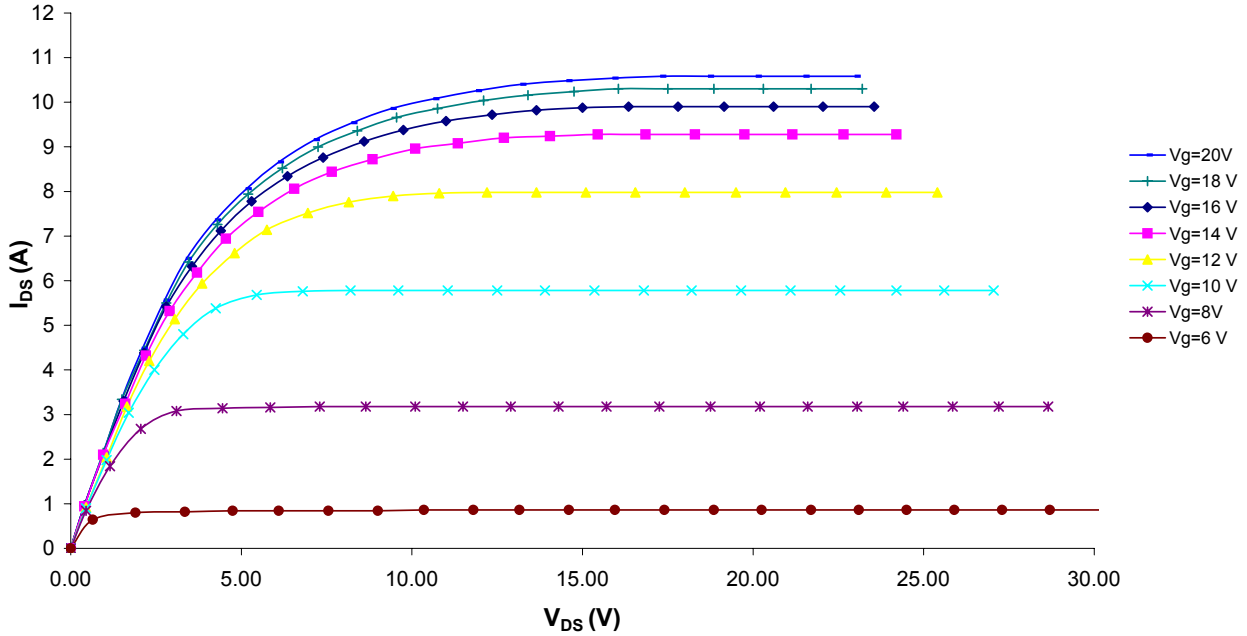


Figure 4 – Typical IV Characteristics.

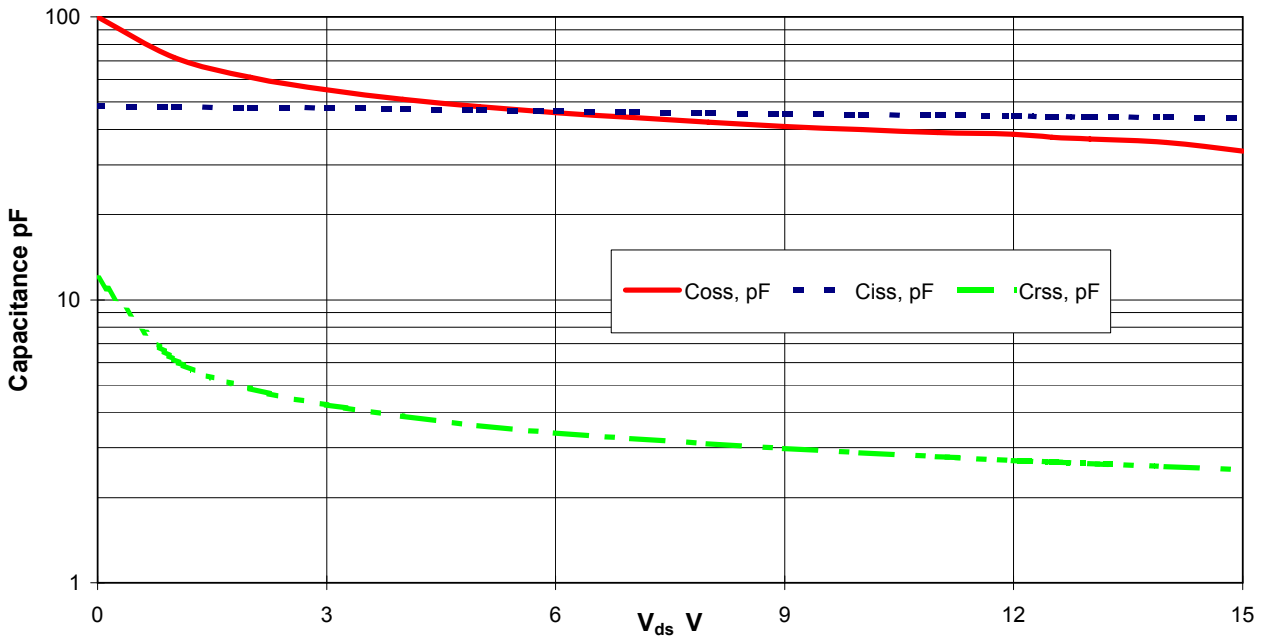
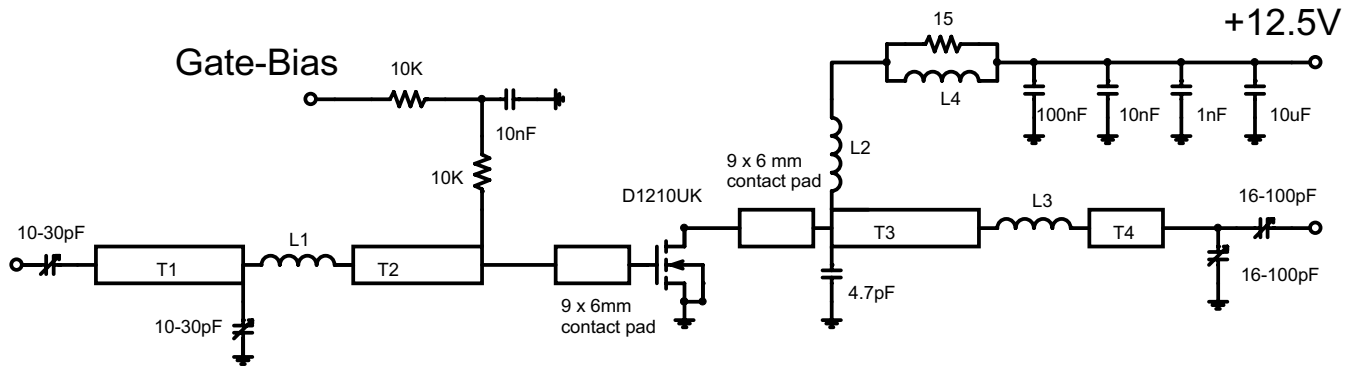


Figure 5 – Typical CV Characteristics.

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Substrate 1.6mm PTFE/glass, Er=2.5

All microstrip lines W=4.4mm

T1 10mm

T2 13mm

T3 12mm

T4 4mm

L1 1.5 turns 22swg enamelled copper wire, 6mm i.d.

L2 10 turns 19swg enamelled copper wire, 6mm i.d.

L3 1.5 turns 22swg enamelled copper wire, 6mm i.d.

L4 13.5 turns 19swg enamelled copper wire on Siemens B64920A618X830 ferrite core

D1210UK 175MHz TEST FIXTURE